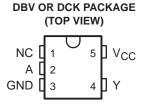
- EPIC™ (Enhanced-Performance Implanted CMOS) Submicron Process
- I<sub>off</sub> Feature Supports Partial-Power-Down Mode Operation
- Supports 5-V V<sub>CC</sub> Operation
- Package Options Include Plastic Small-Outline Transistor (DBV, DCK) Packages



NC - No internal connection

## description

This single Schmitt-trigger inverter is designed for 1.65-V to 5.5-V  $V_{CC}$  operation.

The SN74LVC1G14 device contains one inverter, and performs the Boolean function  $Y = \overline{A}$ . The device functions as an independent inverter, but because of Schmitt action, it may have different input threshold levels for positive-going ( $V_{T+}$ ) and negative-going ( $V_{T-}$ ) signals.

The SN74LVC1G14 is characterized for operation from -40°C to 85°C.

### **FUNCTION TABLE**

	INPUT A	OUTPUT Y
ı	Н	L
ı	L	Н

# logic symbol†



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

### logic diagram (positive logic)





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# absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V <sub>CC</sub>	
Input voltage range, V <sub>I</sub> (see Note 1)	
Output voltage range, VO (see Notes 1 and 2)	0.5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0)	
Output clamp current, I <sub>OK</sub> (V <sub>O</sub> < 0)	–50 mA
Continuous output current, I <sub>O</sub>	±50 mA
Continuous current through V <sub>CC</sub> or GND	±100 mA
Package thermal impedance, $\theta_{JA}$ (see Note 3): DBV package	347°C/W
DCK package	389°C/W
Storage temperature range, T <sub>Stq</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.
  - 2. The value of V<sub>CC</sub> is provided in the recommended operating conditions table.
  - 3. The package thermal impedance is calculated in accordance with JESD 51.

### recommended operating conditions

			MIN	MAX	UNIT		
V/00	Cumply yellogo	Operating	1.65	5.5	V		
Vcc	Supply voltage	Data retention only	1.5		V		
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$	0.65 × V <sub>CC</sub>				
V	High-level input voltage	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.7		V		
VIH VIL VI VO	nigh-level input voltage	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$	V <sub>CC</sub> = 3 V to 3.6 V 2				
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	1.5 0.65 × V <sub>CC</sub> 1.7 2 0.7 × V <sub>CC</sub> 0.35 × V <sub>CC</sub> 0.7 0.8 0.8 0.3 × V <sub>CC</sub> 0 5.5 0 V <sub>CC</sub> -4 -8 -16 -24 -32 4 8				
VII	Low-level input voltage	$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$		0.35 × V <sub>CC</sub>			
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		0.7	V		
VIL		$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$		0.8	V		
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$		$0.3 \times V_{CC}$			
٧ı	Input voltage		0	5.5	V		
۷o	Output voltage		0	VCC	V		
	High-level output current	V <sub>CC</sub> = 1.65 V		-4			
		V <sub>CC</sub> = 2.3 V		-8			
lон		V <sub>CC</sub> = 3 V		-16	mA		
		vCC = 2 v		-24			
		V <sub>CC</sub> = 4.5 V		-32			
	Low-level output current	V <sub>CC</sub> = 1.65 V		4			
		V <sub>CC</sub> = 2.3 V		8			
lOL		V22 - 3 V		16	mA		
		VCC = 3 V		24			
		V <sub>CC</sub> = 4.5 V		32			
TA	Operating free-air temperature		-40	85	°C		



# PRODUCT PREVIEW

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	v <sub>CC</sub>	MIN	TYPŤ	MAX	UNIT			
		1.65 V							
V <sub>T+</sub>		2.3 V				V			
Positive-going input threshold voltage		3 V				V			
amound romage		4.5 V							
		1.65 V							
V <sub>T</sub> -		2.3 V							
Negative-going input threshold voltage		3 V				V			
		4.5 V							
		1.65 V							
ΔVT		2.3 V							
Hysteresis (V <sub>T+</sub> – V <sub>T</sub> –)		3 V				V			
(1)		4.5 V							
	I <sub>OH</sub> = -100 μA	1.65 V to 4.5 V	V <sub>CC</sub> -0.2						
	$I_{OH} = -4 \text{ mA}$	1.65 V	1.2			v			
V	$I_{OH} = -8 \text{ mA}$	2.3 V	1.7						
VOH	$I_{OH} = -16 \text{ mA}$	3 V	2.4			V			
	$I_{OH} = -24 \text{ mA}$	3 V	2.4						
	$I_{OH} = -32 \text{ mA}$	4.5 V	2.2						
	I <sub>OL</sub> = 100 μA	1.65 V to 4.5 V			0.2				
	I <sub>OL</sub> = 4 mA	1.65 V			0.45				
Va.	I <sub>OL</sub> = 8 mA	2.3 V			0.7	V			
VOL	I <sub>OL</sub> = 16 mA	3 V			0.4	v			
	I <sub>OL</sub> = 24 mA	3 V			0.55				
	I <sub>OL</sub> = 32 mA	4.5 V			0.55				
lį	$V_I = 5.5 \text{ V or GND}$	0 to 5.5 V			±5	μΑ			
l <sub>off</sub>	$V_I$ or $V_O = 5.5 V$	0			±10	μΑ			
Icc	$V_I = 5.5 \text{ V or GND}, \qquad I_O = 0$	1.65 V to 5.5 V			10	μΑ			
∆lcc	One input at V <sub>CC</sub> – 0.6 V, Other inputs at V <sub>CC</sub> or GND	3 V to 5.5 V			500	μΑ			
C <sub>i</sub>	$V_I = V_{CC}$ or GND	0				pF			

<sup>†</sup> All typical values are at  $V_{CC} = 3.3 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

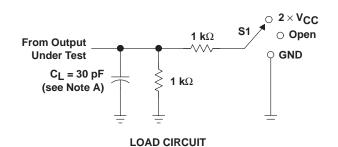
# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 4)

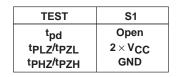
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 1.8 V ± 0.15 V		V <sub>CC</sub> = 2.5 V ± 0.2 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		V <sub>CC</sub> = 5 V ± 0.5 V		UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>pd</sub>	А	Υ									ns

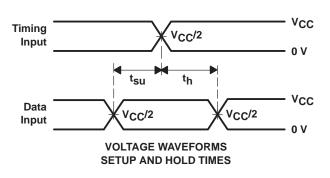
# operating characteristics, $T_A = 25^{\circ}C$

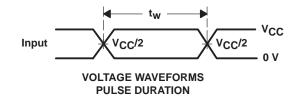
	PARAMETER	TEST CONDITIONS	V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = 2.5 V	$V_{CC} = 3.3 \text{ V}$	V <sub>CC</sub> = 5 V	UNIT	
	FARAWETER	TEST CONDITIONS	TYP	TYP	TYP	TYP	UNIT	
C <sub>pd</sub>	Power dissipation capacitance	f = 10 MHz					pF	

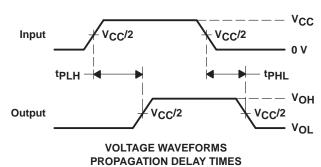
# PARAMETER MEASUREMENT INFORMATION $V_{CC}$ = 1.8 V $\pm$ 0.15 V

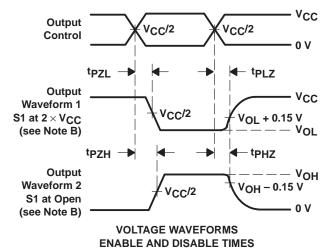












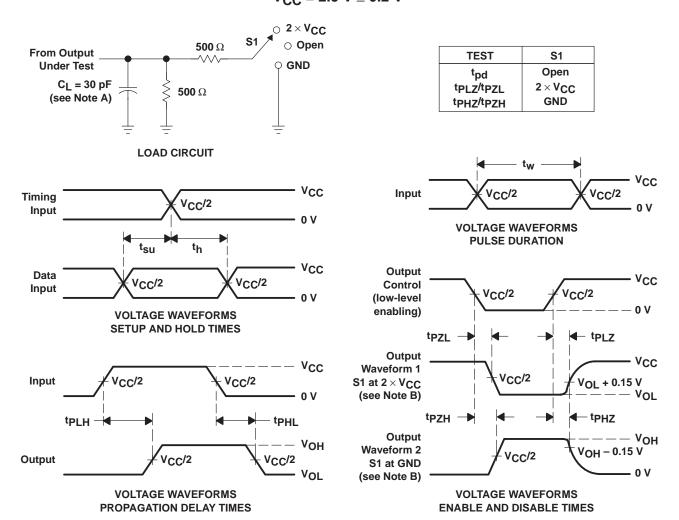
NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_Q = 50 \ \Omega$ ,  $t_f \leq$  2 ns,  $t_f \leq$  2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. tpzL and tpzH are the same as ten.
- G. tplH and tpHL are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



# PARAMETER MEASUREMENT INFORMATION $V_{CC} = 2.5 \text{ V} \pm 0.2 \text{ V}$

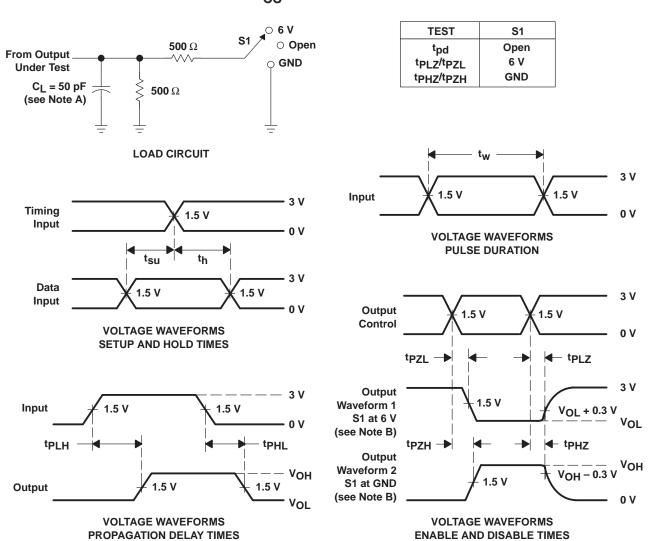


NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_f \leq 2$  ns.
- D. The outputs are measured one at a time with one transition per measurement.
- E. tpLz and tpHz are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpLH and tpHL are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms

# PARAMETER MEASUREMENT INFORMATION $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$



- NOTES: A.  $C_L$  includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_Q = 50 \Omega$ ,  $t_f \leq 2.5 \text{ ns.}$
  - D. The outputs are measured one at a time with one transition per measurement.
  - E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
  - F. tpzL and tpzH are the same as ten.
  - G. tpLH and tpHL are the same as tpd.

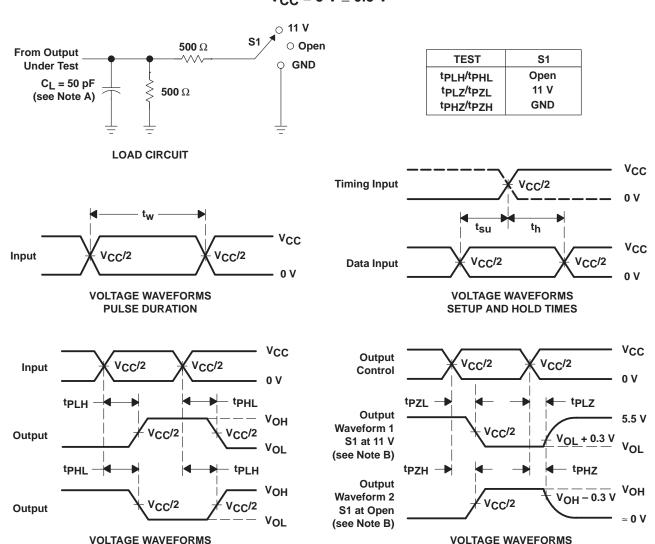
Figure 3. Load Circuit and Voltage Waveforms



**ENABLE AND DISABLE TIMES** 

LOW- AND HIGH-LEVEL ENABLING

# PARAMETER MEASUREMENT INFORMATION $V_{CC}$ = 5 V $\pm$ 0.5 V



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_Q = 50 \Omega$ ,  $t_f \leq 2.5 \text{ ns.}$
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .

PROPAGATION DELAY TIMES

INVERTING AND NONINVERTING OUTPUTS

- F. tpzL and tpzH are the same as ten.
- G. tpl H and tpHI are the same as tpd.

Figure 4. Load Circuit and Voltage Waveforms

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